

Search Notes		Application No.	Applicant(s)
		10/016,794	HEEB, BEAT
		Examiner	Art Unit
		Hoang-Vu A Nguyen-Ba	2122

SEARCHED			
Class	Subclass	Date	Examiner
717	151-153	8/31/2004	HAN
717	114,116	8/31/2004	HAN
717	118,126	8/31/2004	HAN
717	136,139	8/31/2004	HAN
717	140,146	8/31/2004	HAN
717	148	8/31/2004	HAN
718	1	8/31/2004	HAN
Previous search updated	3/15/05	Han	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor search	8/27/2004	HAN
East Search: USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB	8/31/2004	HAN
Non Patent Literature Search: Google	8/31/2004	HAN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
717	148	3/15/05	Han
717	118		
717	153		